



Form PTO-1449

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
M122-1518SERIAL NO.
09/653,156LIST OF ART CITED BY APPLICANT
(Use several sheets if necessary)

APPLICANT Vishnu K. Agarwal

FILING DATE
August 31, 2000GROUP
2813

U.S. PATENT DOCUMENTS

*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
TN	AA	6,270,572	08/01	Kim et al	—	—	—
	AB						
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FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER

DATE CONSIDERED

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Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. M122-1518		SERIAL NO. 09/653,156	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Vishoo K. Agarwal			
				FILING DATE August 31, 2000		GROUP 2831	
U.S. PATENT DOCUMENTS							
Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
JP	AA 6,281,142	06/1999	Basceri et al				
JP	AB 6,204,172	09/1998	Marsh				
JP	AC 5,432,732	07/1995	Obami				
JP	AD 6,242,299	06/2001	Hickert				
JP	AE 6,249,056	06/2001	Kwon				
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EXAMINER <i>JPB</i>				DATE CONSIDERED 5/3/02			
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		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. M122-1518		SERIAL NO. 09653.156		
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Vishnu K. Agarwal				
				FILING DATE August 31, 2000		GROUP 2831		
U.S. PATENT DOCUMENTS								
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
47	AA	09652.532		Dendrian (as amended 11/29/2001)			08/31/2000 KC 5/1/2002	
	AB			The document isn't available for review				
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FOREIGN PATENT DOCUMENTS								
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47				5/3/02				

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U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

LIST OF ART CITED BY APPLICANT
(Indicate pertinent sheets if necessary)

ATTY. DOCKET NO.
M122-1518

SERIAL NO.
09/633,156

APPLICANT Vishou K. Agarwal

FILING DATE
August 31, 2000

GROUP
2813

U.S. PATENT DOCUMENTS

*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate
U	AA 6,335,240	01-2002	Kim et al			
U	AB 5,156,606	12-2000	Michaelis			
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FOREIGN PATENT DOCUMENTS

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					Yes	No
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER *U/Km*

DATE CONSIDERED 9/13/02

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Form 1-100 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. M12-1518		SERIAL NO. 09/633,156	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Vishnu K. Agarwal	
FILING DATE August 31, 2000				GROUP 283	

U.S. PATENT DOCUMENTS							
*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
	AA	6,180,481	01/2001	DeBoer et al	—	—	—
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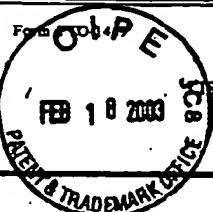
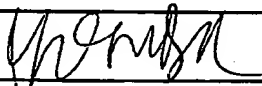
FOREIGN PATENT DOCUMENTS							
Document Number	Date	Country	Class	Subclass	Translation		
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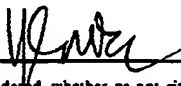
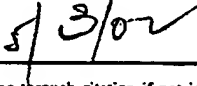
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		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-1518		SERIAL NO. 09/653,156		
		LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Vishnu K. Agarwal		
		FILING DATE August 31, 2000		GROUP 2813				
U.S. PATENT DOCUMENTS								
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
OK	AA	2002/0064915A1	05/2002	Kitamura				
OK	AB	2001/0023110A1	09/2001	Fukuzumi et al				
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FOREIGN PATENT DOCUMENTS								
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							Yes	No
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Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. M122-1518		SERIAL NO. 09/653,156	
 <p>STATE OF ART CITED BY APPLICANT (Use several sheets if necessary)</p>				APPLICANT Vishnu K. Agarwal			
				FILING DATE August 31, 2000		GROUP 2831	
U.S. PATENT DOCUMENTS							
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
42	AA	5,641,984	06/1997	Aftergut et al	—	—	—
42	AB	6,216,260	04/2001	Lee et al	—	—	—
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
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